

MOS FIELD EFFECT TRANSISTOR 2SK3305

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The 2SK3305 is N-Channel DMOS FET device that features a low gate charge and excellent switching characteristics, and designed for high voltage applications such as switching power supply, AC adapter.

ORDERING INFORMATION

| PART NUMBER | PACKAGE |
|-------------|----------|
| 2SK3305 | TO-220AB |
| 2SK3305-S | TO-262 |
| 2SK3305-ZJ | TO-263 |

FEATURES

- · Low gate charge:
 - $Q_G = 13 \text{ nC TYP.}$ (VDD = 400 V, VGS = 10 V, ID = 5.0 A)
- Gate voltage rating: ±30 V
- · Low on-state resistance

 $RDS(on) = 1.5 \Omega MAX. (VGS = 10 V, ID = 2.5 A)$

· Avalanche capability ratings

(TO-220AB)



(TO-262)



(TO-263)



ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

| Drain to Source Voltage (Vgs = 0 V) | Voss | 500 | V |
|---|--------------------|-------------|----|
| Gate to Source Voltage (VDS = 0 V) | VGSS(AC) | ±30 | V |
| Drain Current (DC) | I _{D(DC)} | ±5 | Α |
| Drain Current (pulse) Note1 | ID(pulse) | ±20 | Α |
| Total Power Dissipation (Tc = 25°C) | Рт | 75 | W |
| Total Power Dissipation (T _A = 25°C) | PT | 1.5 | W |
| Channel Temperature | Tch | 150 | °C |
| Storage Temperature | Tstg | -55 to +150 | °C |
| Single Avalanche Current Note2 | las | 5.0 | Α |
| Single Avalanche Energy Note2 | Eas | 125 | mJ |

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1 %

2. Starting Tch = 25 °C, VDD = 150 V, RG = 25 Ω , VGS = 20 V \rightarrow 0 V

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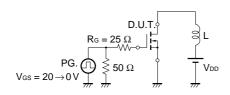
Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

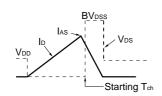


ELECTRICAL CHARACTERISTICS (TA = 25 °C)

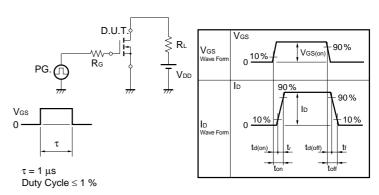
| CHARACTERISTICS | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-------------------------------------|----------------------|--|------|------|------|------|
| Drain Leakage Current | IDSS | V _{DS} = 500 V, V _{GS} = 0 V | | | 100 | μΑ |
| Gate to Source Leakage Current | Igss | Vgs = ±30 V, Vps = 0 V | | | ±100 | nA |
| Gate to Source Cut-off Voltage | V _{GS(off)} | V _{DS} = 10 V, I _D = 1 mA | 2.5 | | 3.5 | V |
| Forward Transfer Admittance | yfs | V _{DS} = 10 V, I _D = 2.5 A | 1.0 | 3.0 | | S |
| Drain to Source On-state Resistance | RDS(on) | V _G S = 10 V, I _D = 2.5 A | | 1.3 | 1.5 | Ω |
| Input Capacitance | Ciss | Vps = 10 V, Vps = 0 V, f = 1 MHz | | 700 | | pF |
| Output Capacitance | Coss | | | 115 | | pF |
| Reverse Transfer Capacitance | Crss | | | 6 | | pF |
| Turn-on Delay Time | td(on) | $V_{DD} = 150 \text{ V}, I_D = 2.5 \text{ A}, V_{GS(on)} = 10 \text{ V},$ | | 16 | | ns |
| Rise Time | tr | $R_G = 10~\Omega,~R_L = 60~\Omega$ | | 3 | | ns |
| Turn-off Delay Time | td(off) | | | 33 | | ns |
| Fall Time | tf | | | 5.5 | | ns |
| Total Gate Charge | QG | V _{DD} = 400 V, V _{GS} = 10 V, I _D = 5.0 A | | 13 | | nC |
| Gate to Source Charge | Qgs | | | 4 | | nC |
| Gate to Drain Charge | Q _{GD} | | | 4.5 | | nC |
| Body Diode Forward Voltage | V _F (S-D) | IF = 5.0 A, VGS = 0 V | | 0.9 | | V |
| Reverse Recovery Time | trr | $I_F = 5.0 \text{ A}, \text{ Vgs} = 0 \text{ V}, \text{ di/dt} = 50 \text{ A}/\mu\text{s}$ | | 0.6 | | μs |
| Reverse Recovery Charge | Qrr | | | 3.3 | | μC |

TEST CIRCUIT 1 AVALANCHE CAPABILITY

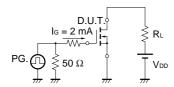




TEST CIRCUIT 2 SWITCHING TIME



TEST CIRCUIT 3 GATE CHARGE





TYPICAL CHARACTERISTICS (TA = 25°C)

Figure 1. DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA

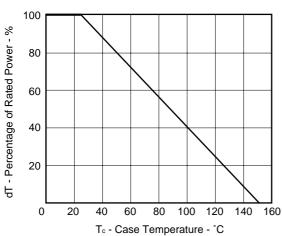


Figure 3. FORWARD BIAS SAFE OPERATING AREA

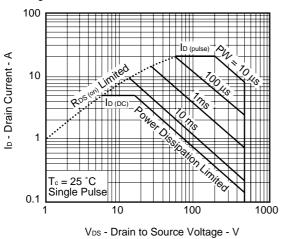


Figure 5. DRAIN CURRENT vs.

GATE TO SOURCE VOLTAGE

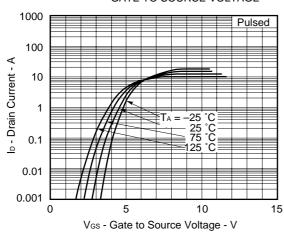


Figure 2. TOTAL POWER DISSIPATION vs. CASE TEMPERATURE

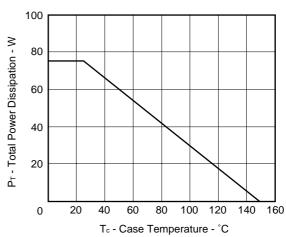
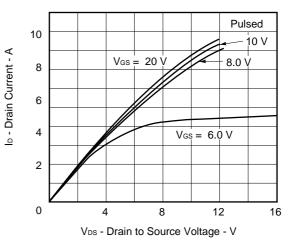


Figure4. DRAIN CURRENT vs.
DRAIN TO SOURCE VOLTAGE



3

Figure 6. TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

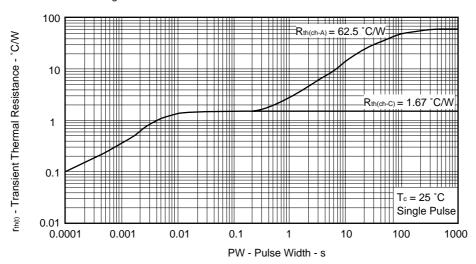


Figure7. FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

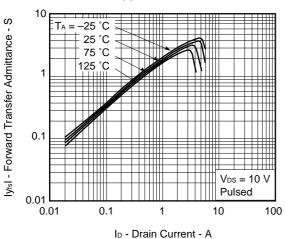


Figure9. DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

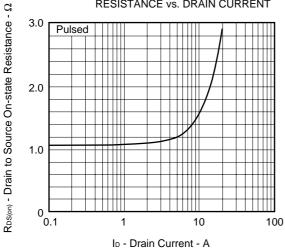


Figure8. DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

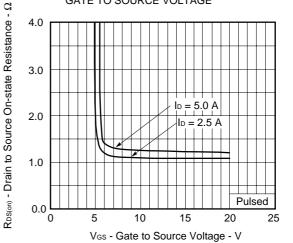
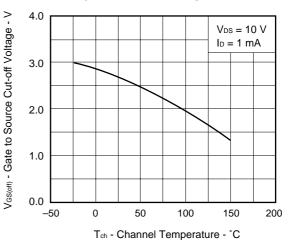


Figure 10. GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE





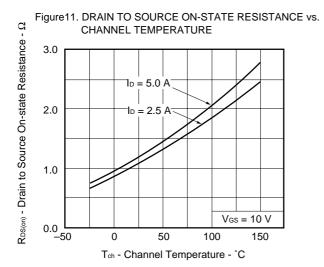


Figure 13. CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE

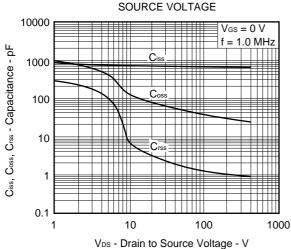


Figure 15. REVERSE RECOVERY TIME vs. DRAIN CURRENT

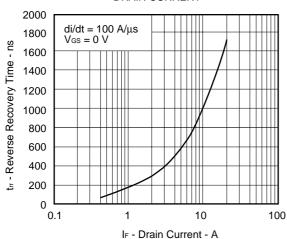


Figure 12. SOURCE TO DRAIN DIODE FORWARD VOLTAGE

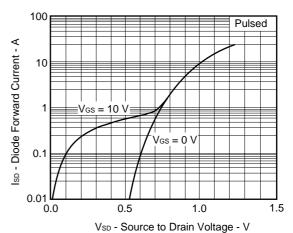


Figure 14. SWITCHING CHARACTERISTICS

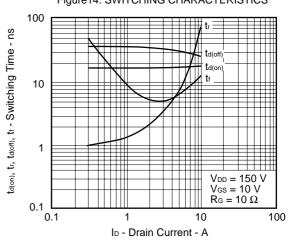


Figure 16. DYNAMIC INPUT/OUTPUT CHARACTERISTICS

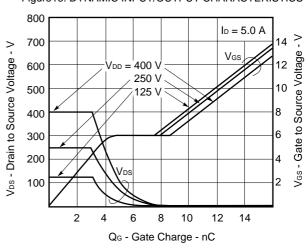


Figure 17. SINGLE AVALANCHE ENERGY vs STARTING CHANNEL TEMPERATURE

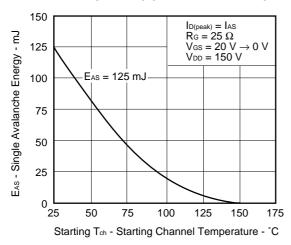
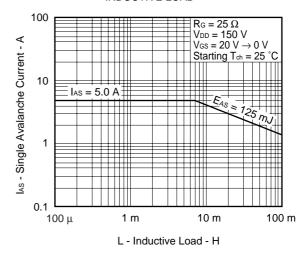


Figure 18. SINGLE AVALANCHE CURRENT vs INDUCTIVE LOAD

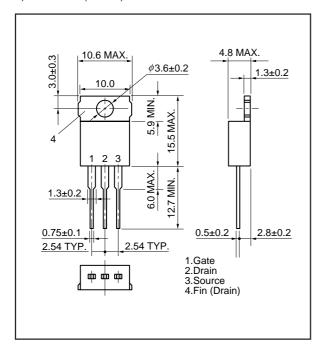


6

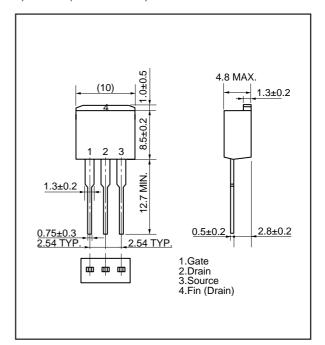


PACKAGE DRAWINGS (Unit: mm)

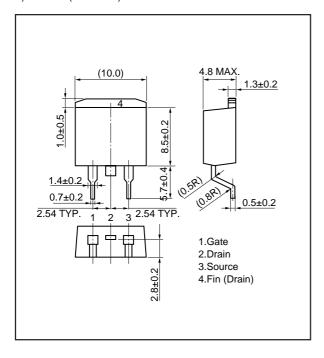
1) TO-220AB (MP-25)



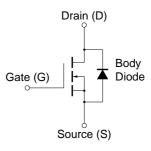
2) TO-262 (MP-25 Fin Cut)



3) TO-263 (MP-25ZJ)



EQUIVALENT CIRCUIT



Remark Strong electric field, when exposed to this device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred.

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